



DONGGUAN VENUS OPTOELECTRONIC CO.,LTD

CE EMC REPORT

Prepared For :	DONGGUAN VENUS OPTOELECTRONIC CO.,LTD
	Huguang Rd, Jiuwei, Qishi Town, Dongguan, Guangdong, China
Product Name:	LED FILAMENT BULB
Trade Name:	Venusop
Model :	ST64, C7-YSYW, C35-YSYW, C35L-YSYW, G45-YSYW, G50-YSYW, A15-YSYW, A17-YSYW, A19-YSYW, A21-YSYW, A23-YSYW, A25-YSYW, G80-YSYW, G95-YSYW, G95-YSYW, G125-YSYW, G125-YSYW, D110-YSYW, D120-YSYW, ST38-YSYW, ST48-YSYW, ST58-YSYW, ST64-YSYW, ST64-YSYW, T20-YSYW, T22-YSYW, T25-YSYW, ST26-YSYW, T38-YSYW, T45-YSYW, T30S-YSYW, T30M-YSYW, T30L-YSYW, R39-YSYW, R50-YSYW, R63-YSYW, R80-YSYW, R95-YSYW, A19-30LED, G80-47LED, G95-47LED, G125-47LED, ST58-47LED, ST64-47LED, T22-20SMD, ST26-20SMD, C35-45SMD, A19-45SMD, BR30, (Y=1,2,3,4,5,6,7,8,9,10,12)
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Test Date:	Sept. 12-13, 2016
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Report No.:	BST16098401A0001Y-1ER-1



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TEST REPORT DECLARATION

Applicant	: DONGGUAN VENUS OPTOELECTRONIC CO.,LTD
Address	: Huguang Rd, Jiuwei, Qishi Town, Dongguan, Guangdong, China
EUT Description	: LED FILAMENT BULB
Model Number	: ST64, C7-YSYW, C35-YSYW, C35L-YSYW, G45-YSYW, G50-YSYW, A15-YSYW, A17-YSYW, A19-YSYW, A21-YSYW, A23-YSYW, A25-YSYW, G80-YSYW, G95-YSYW, G95-YSYW, G125-YSYW, G125-YSYW, D110-YSYW, D120-YSYW, ST38-YSYW, ST48-YSYW, ST58-YSYW, ST64-YSYW, ST64-YSYW, T20-YSYW, T22-YSYW, T25-YSYW, ST26-YSYW, T38-YSYW, T45-YSYW, T30S-YSYW, T30M-YSYW, T30L-YSYW, R39-YSYW, R50-YSYW, R63-YSYW, R80-YSYW, R95-YSYW, A19-30LED, G80-47LED, G95-47LED, G125-47LED, ST58-47LED, ST64-47LED, T22-20SMD, ST26-20SMD, C35-45SMD, A19-45SMD, BR30, (Y=1,2,3,4,5,6,7,8,9,10,12) (Note: The series products have the same circuit diagram, PCB layout and functionality. The differences are the model name and appearance, so, we select ST64 to test.)



Test Standards:

EN55015:2013
EN61547:2009
EN61000-3-2:2006+A1:2009+A2:2009
EN61000-3-3:2013

The device described above is tested by us with the listed standards and found that **ST64, C7-YSYW, C35-YSYW, C35L-YSYW, G45-YSYW, G50-YSYW, A15-YSYW, A17-YSYW, A19-YSYW, A21-YSYW, A23-YSYW, A25-YSYW, G80-YSYW, G95-YSYW, G95-YSYWX, G125-YSYW, G125-YSYWX, D110-YSYW, D120-YSYW, ST38-YSYW, ST48-YSYW, ST58-YSYW, ST64-YSYW, ST64-YSYWX, T20-YSYW, T22-YSYW, T25-YSYW, ST26-YSYW, T38-YSYW, T45-YSYW, T30S-YSYW, T30M-YSYW, T30L-YSYW, R39-YSYW, R50-YSYW, R63-YSYW, R80-YSYW, R95-YSYW, A19-30LED, G80-47LED, G95-47LED, G125-47LED, ST58-47LED, ST64-47LED, T22-20SMD, ST26-20SMD, C35-45SMD, A19-45SMD, BR30, (Y=1,2,3,4,5,6,7,8,9,10,12)** have the same electronic circuit and PCB layout with “**ST64**” except the model name.“**ST64**” has passed EMC tests(Report NO. **BST1501396490001Y-1ER-1** has the detailed content). So,no tests are necessary. The test results are contained in this test report.

Shenzhen BST Technology Co., Ltd. .is assumed of full responsibility for the accuracy and completeness of these tests. Also, this report shows that the EUT is technically compliant with the EN55015, EN55024 standards.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen BST Technology Co., Ltd.

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Reviewer :

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1. TEST RESULTS SUMMARY

Table 1 Test Results Summary

Test Items	Test Results
Power Line Conducted Emission Test	PASS
Magnetic Test	PASS
Radiated Emission	PASS
Harmonic Current Emission Test	PASS
Voltage Fluctuations & Flicker Test	PASS
Electrostatic Discharge Test	PASS
RF Field Strength Susceptibility Test	PASS
Electrical Fast Transient/Burst Test	PASS
Surge Test	PASS
Injected Currents Susceptibility Test	PASS
Magnetic Field Immunity Test	PASS
Voltage Dips And Interruptions Test	PASS



2. GENERAL INFORMATION

2.1. Report information

- 2.1.1. This report is not a certificate of quality; it only applies to the sample of the specific product/equipment given at the time of its testing. The results are not used to indicate or imply that they are application to the similar items. In addition, such results must not be used to indicate or imply that BST approves recommends or endorses the manufacture, supplier or use of such product/equipment, or that BST in any way guarantees the later performance of the product/equipment.
- 2.1.2. The sample/s mentioned in this report is/are supplied by Applicant, BST therefore assumes no responsibility for the accuracy of information on the brand name, model number, origin of manufacture or any information supplied.
- 2.1.3. Additional copies of the report are available to the Applicant at an additional fee. No third part can obtain a copy of this report through BST, unless the applicant has authorized BST in writing to do so.

2.2. Measurement Uncertainty

(95% confidence levels, k=2)

Test Item	Uncertainty
Uncertainty for Conduction emission test	2.2dB
Uncertainty for Magnetic emission test	3.3dB
Uncertainty for Radiation emission test (30MHz to 1GHz)	4.0dB

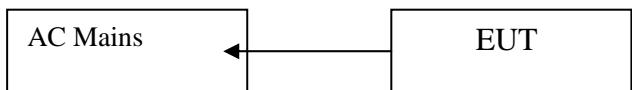


3. PRODUCT DESCRIPTION

3.1. EUT Description

Description	:	LED FILAMENT BULB
Applicant	:	DONGGUAN VENUS OPTOELECTRONIC CO.,LTD Huguang Rd, Jiuwei, Qishi Town, Dongguan, Guangdong, China
Manufacturer	:	DONGGUAN VENUS OPTOELECTRONIC CO.,LTD Huguang Rd, Jiuwei, Qishi Town, Dongguan, Guangdong, China
Model Number	:	ST64, C7-YSYW, C35-YSYW, C35L-YSYW, G45-YSYW, G50-YSYW, A15-YSYW, A17-YSYW, A19-YSYW, A21-YSYW, A23-YSYW, A25-YSYW, G80-YSYW, G95-YSYW, G95-YSYWX, G125-YSYW, G125-YSYWX, D110-YSYW, D120-YSYW, ST38-YSYW, ST48-YSYW, ST58-YSYW, ST64-YSYW, ST64-YSYWX, T20-YSYW, T22-YSYW, T25-YSYW, ST26-YSYW, T38-YSYW, T45-YSYW, T30S-YSYW, T30M-YSYW, T30L-YSYW, R39-YSYW, R50-YSYW, R63-YSYW, R80-YSYW, R95-YSYW, A19-30LED, G80-47LED, G95-47LED, G125-47LED, ST58-47LED, ST64-47LED, T22-20SMD, ST26-20SMD, C35-45SMD, A19-45SMD, BR30, (Y=1,2,3,4,5,6,7,8,9,10,12)

3.2. Block Diagram of EUT Configuration



3.3. Operating Condition of EUT

Test mode 1: ON

3.4. Test Conditions

Temperature: 23-26°C

Relative Humidity: 55-68 %

3.5. Modifications

No modification was made.



3.6. Abbreviations

AC	Alternating Current
AMN	Artificial Mains Network
DC	Direct Current
EM	ElectroMagnetic
EMC	ElectroMagnetic Compatibility
EUT	Equipment Under Test
IF	Intermediate Frequency
RF	Radio Frequency
rms	root mean square
EMI	Electromagnetic Interference
EMS	Electromagnetic Susceptibility

3.7. Performance Criterion

Criterion A: The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

Criterion B: After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.

Criterion C: Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.



4. TEST EQUIPMENT USED

4.1. For Conducted Emission Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Test Receiver	Rohde & Schwarz	ESHS30	828985/018	Jun. 01, 16	1 Year
2.	Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100006	Jun. 01, 16	1 Year
3.	L.I.S.N.	Rohde & Schwarz	ESH2-Z5	834549/005	Jun. 01, 16	1 Year
4.	Conical	Emtek	N/A	N/A	N/A	N/A
5.	Voltage Probe	Schwarzbeck	TK9416	N/A	Jun. 01, 16	1 Year
6.	Coaxial Switch	Anritsu	MP59B	6100214550	Jun. 01, 16	1 Year

4.2. For Magnetic Test (In Shielding Room)

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Test Receiver	Rohde & Schwarz	ESHS20	836600/006	Jun. 04, 16	1 Year
2.	Triple-loop Antenna	Rohde & Schwarz	HM020	843885/002	Jun. 05, 16	1 Year
3.	RF Cable	MIYAZAKI	5D-2W	Tri-loop Cable	Oct. 28, 16	1/2 Year
4.	Coaxial Switch	Anritsu	MP59B	M73989	Dec. 04, 16	1/2 Year

4.3. For Radiated Emission Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Spectrum Analyzer	ANRITSU	MS2661C	6200140915	Jun. 01, 16	1 Year
2.	Test Receiver	Rohde&Schwarz	ESC830	828982/018	Jun. 01, 16	1 Year
3.	Bilog Antenna	Schwarzbeck	VULB9163	142	Jun. 01, 16	1 Year
4.	50 Coaxial Switch	Anritsu Corp	MP59B	6100237248	Jun. 01, 16	1 Year
5.	Cable	Schwarzbeck	AK9513	ACRX1	Jun. 01, 16	1 Year
6.	Cable	Rosenberger	N/A	FR2RX2	Jun. 01, 16	1 Year
7.	Cable	Schwarzbeck	AK9513	CRRX2	Jun. 01, 16	1 Year
8.	Cable	Schwarzbeck	AK9513	CRRX2	Jun. 01, 16	1 Year
9.	Signal Generator	HP	864A	3625U00573	Jun. 01, 16	1 Year

4.4. For Harmonic / Flicker Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Harmonic and Flicker analyzer	Laplace	AC2000A	309709	Oct. 15, 2015	1 Year

4.5. For Electrostatic Discharge Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	ESD Tester	HAEFELY	PSD 1600	H911'292	Jun. 02, 16	1 Year



4.6. For RF Strength Susceptibility Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Signal Generator	HP	8648A	3633A02081	Jun. 03, 16	1 Year
2.	Amplifier	A&R	500A100	17034	NCR	NCR
3.	Amplifier	A&R	100W/1000M1	17028	NCR	NCR
4.	Isotropic Field Monitor	A&R	FM2000	16829	NCR	NCR
5.	Isotropic Field Probe	A&R	FLW220100	16755	Jun. 03, 16	1 Year
6.	Biconic Antenna	EMCO	3108	9507-2534	NCR	NCR
7.	Log-periodic Antenna	A&R	AT1080	16812	NCR	NCR
8.	PC	N/A	486DX2	N/A	N/A	N/A

4.7. For Electrical Fast Transient/Burst Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Burst Tester	HAEFELY	PEFT 4010	080981-16	Jun. 01, 16	1 Year

4.8. For Surge Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Surge Tester	HAEFELY	PSURGE4.1	080107-04	Jun. 01, 16	1 Year

4.9. For Injected Currents Susceptibility Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Simulator	EMTEST	CWS 500C	0900-12	Jun. 01, 16	1 Year
2.	CDN	EMTEST	CDN-M2	510010010010	Jun. 01, 16	1 Year
3.	VDN	EMTEST	CDN-M3	0900-11	Jun. 01, 16	1 Year
4.	Injection Clamp	EMTEST	F-2031-23MM	368	Jun. 01, 16	1 Year
5.	Attenuator	EMTEST	ATT6	0010222a	Jun. 01, 16	1 Year

4.10. For Magnetic Field Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Magnetic Field Tester	HEAFELY	MAG100.1	083858-10	Jun. 01, 16	1 Year

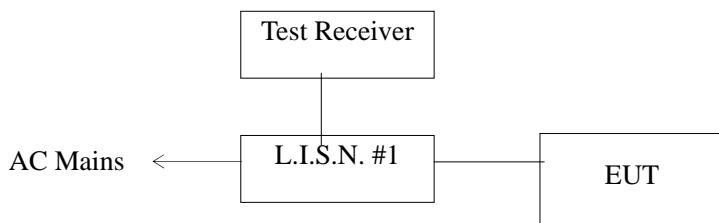
4.11. For Voltage Dips and Interruptions Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
2.	Dips Tester	HEAFELY	PLINE 1610	083732-18	Jun. 01, 16	1 Year



5. POWER LINE CONDUCTED EMISSION TEST

5.1. Block Diagram of Test Setup



5.2. Test Standard

EN55015:2013

5.3. Power Line Conducted Emission Limit

Frequency	At mains terminals (dB μ V)	
	Quasi-peak Level	Average Level
9KHz ~ 50KHz	110	--
50KHz ~ 150KHz	90 ~ 80*	--
150KHz ~ 0.5MHz	66 ~ 56*	56 ~ 46*
0.5MHz ~ 2.51MHz	56	46
2.51MHz ~ 3.0MHz	73	63
3.0MHz ~ 5.0MHz	56	46
5.0MHz ~ 30MHz	60	50

1. At the transition frequency the lower limit applies.
2. * decreasing linearly with logarithm of the frequency.

5.4. EUT Configuration on Test

The following equipments are installed on conducted emission test to meet EN55015 requirement and operating in a manner, which tends to maximize its emission characteristics in a normal application.

5.4.1. EUT Information

Model Number : ST64
Serial Number : N/A
Manufacturer : DONGGUAN VENUS OPTOELECTRONIC CO.,LTD



5.5. Operating Condition of EUT

- 5.5.1. Setup the EUT and simulators as shown in Section 5.1.
- 5.5.2. Turn on the power of all equipments.
- 5.5.3. Let the EUT work in test mode (ON) and test it.

5.6. Test Procedure

The EUT is put on the table which is 0.8 meter high above the ground and connected to the AC mains through a Line Impedance Stabilization Network (L.I.S.N.). This provided a 50ohm coupling impedance for the tested equipments. Both sides of AC line are checked to find out the maximum conducted emission according to the EN55015 regulations during conducted emission test. And the voltage probe had been used for the load terminals test according to the EN55015 standard.

The bandwidth of the test receiver is set at 9kHz. in 150KHz~30MHz and 200Hz bandwidth in 9KHz~150KHz.

The frequency range from 9kHz to 30MHz is checked.

All the test results are listed in Section 5.7. The scanning waveform is put in **Appendix I**.

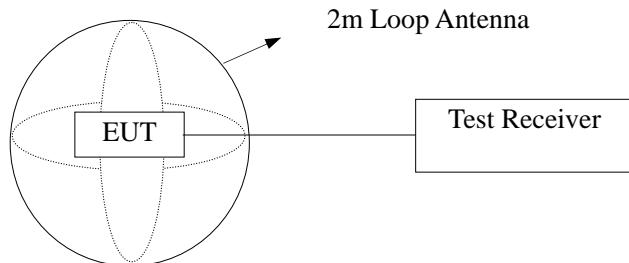
5.7. Test Result

PASS.



6. MAGNETIC TEST

6.1. Block Diagram of Test Setup



(EUT: LED FILAMENT BULB)

6.2. Test Standard

EN55015:2013

6.3. Magnetic Field Emission Limits

Frequency	Limits for loop diameter (dBμA)	
	2m	
9KHz ~ 70KHz	88	
70KHz ~ 150KHz	88 ~ 58*	
150KHz ~ 2.2MHz	58 ~ 26*	
2.2MHz ~ 3.0MHz	58	
3.0MHz ~ 30MHz	22	

1. At the transition frequency the lower limit applies.
2. * decreasing linearly with logarithm of the frequency.

6.4. EUT Configuration on Test

The configuration of the EUT is same as Section 3.2..

6.5. Operating Condition of EUT

- 6.5.1. Setup the EUT as shown in Section 6.1.
- 6.5.2. Turn on the power of all equipments.
- 6.5.3. Let the EUT work in test mode (ON) and test it.



6.6. Test Procedure

The EUT is placed on a wood table in the center of a loop antenna. The induced current in the loop antenna is measured by means of a current probe and the test receiver. Three field components is checked by means of a coax switch.

The frequency range from 9kHz to 30MHz is investigated. The receiver is measured with the quasi-peak detector. For frequency band 9kHz to 150KHz, the bandwidth of the field strength meter is set at 200Hz. For frequency band 150KHz to 30MHz , the bandwidth is set at 10KHz.

All the test results are listed in Section 6.7. and all the scanning waveform is put in **Appendix II**.

6.7. Test Results

PASS.

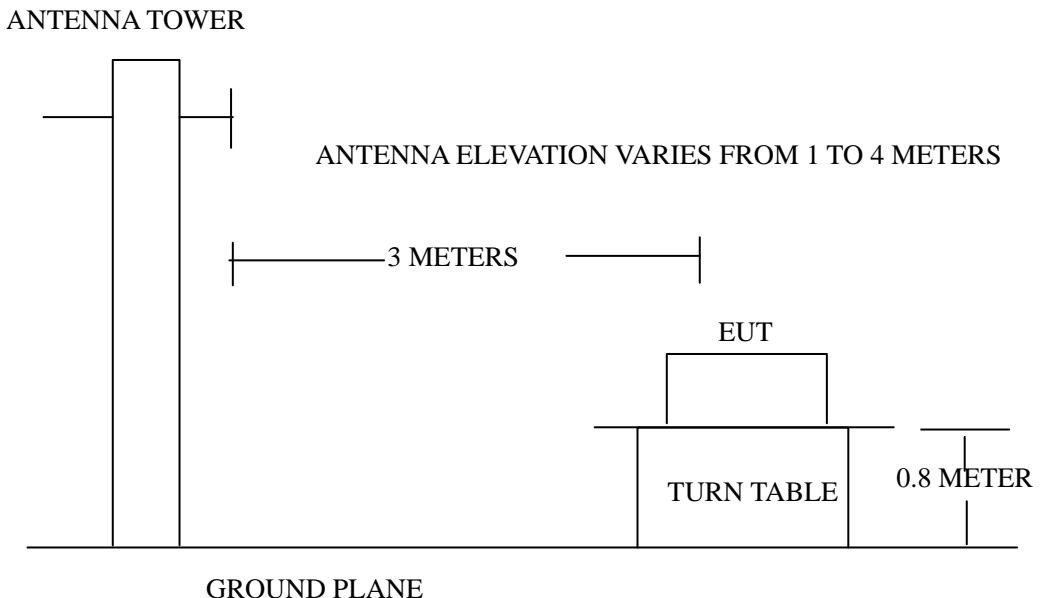
The frequency range from 9kHz to 30MHz is investigated.

As the peak value is too low against the limit, so the Quasi-peak value has been omitted.



7. RADIATED EMISSION TEST

7.1. Semi-Anechoic Chamber Setup Diagram



7.2. Test Standard

EN55015:2013

7.3. Radiated Emission Limit

All emanations from a computing devices or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified below:

FREQUENCY (MHz)	DISTANCE (Meters)	FIELD STRENGTHS LIMITS (dB μ V/m)
30 ~ 230	3	40
230 ~ 300	3	47

Note:(1) The tighter limit shall apply at the edge between two frequency bands.

(2) Distance refers to the distance in meters between the measuring instruments antenna and the closed point of any part of the EUT.

7.4. EUT Configuration on Test

The EN55015 regulations test method must be used to find the maximum emission during radiated emission test.



7.5. Operating Condition of EUT

- 7.5.1. Setup the EUT as shown on Section 7.1.
- 7.5.2. Turn on the power of all equipments.
- 7.5.3. Let the EUT work in test mode (ON) and test it.

7.6. Test Procedure

The EUT is placed on a turn table which is 0.8 meter above ground. The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can move up and down between 1 to 4 meters to find out the maximum emission level. Broadband antenna (calibrated by dipole antenna) are used as a receiving antenna. Both horizontal and vertical polarization of the antenna are set on test.

The bandwidth setting on the test receiver is 120 KHz.

The EUT is tested in Semi-Anechoic Chamber. and all the scanning waveform is put in **Appendix III.**

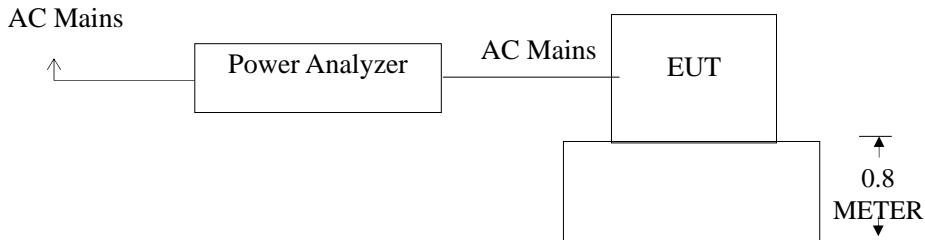
7.7. Test Results

PASS.



8. HARMONIC CURRENT EMISSION TEST

8.1. Block Diagram of Test Setup



(EUT: LED FILAMENT BULB)

8.2. Test Standard

EN61000-3-2:2006+A1:2009+A2:2009

Class C

8.3. Operating Condition of EUT

- 8.3.1. Setup the EUT as shown in Section 8.1.
- 8.3.2. Turn on the power of all equipments.
- 8.3.3. Let the EUT work in test mode (ON) and test it.

8.4. Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the Power of the EUT and use the test system to test the harmonic current level.

8.5. Test Results

PASS.

**Average harmonic current results**

Hn	Ieff [A]	Ieff [%]	Limit [%]	Result
2	643.854E-6	0.308	2.00	PASS
3	34.646E-3	16.574	28.78	PASS
4	585.303E-6	0.280		PASS
5	1.618E-3	0.774	10.00	PASS
6	627.926E-6	0.300		PASS
7	13.165E-3	6.298	7.00	PASS
8	585.277E-6	0.280		PASS
9	2.347E-3	1.123	5.00	PASS
10	577.112E-6	0.276		PASS
11	8.990E-3	2.901	3.00	PASS
12	606.176E-6	0.290		PASS
13	770.152E-6	0.368	3.00	PASS
14	918.463E-6	0.439		PASS
15	5.977E-3	2.859	3.00	PASS
16	568.535E-6	0.272		PASS
17	2.112E-3	1.010	3.00	PASS
18	632.016E-6	0.302		PASS
19	4.910E-3	2.349	3.00	PASS
20	646.103E-6	0.309		PASS
21	3.480E-3	1.665	3.00	PASS
22	614.498E-6	0.294		PASS
23	2.163E-3	1.035	3.00	PASS
24	578.800E-6	0.277		PASS
25	2.539E-3	1.215	3.00	PASS
26	660.642E-6	0.316		PASS
27	1.810E-3	0.866	3.00	PASS
28	630.027E-6	0.301		PASS
29	1.330E-3	0.636	3.00	PASS
30	573.405E-6	0.274		PASS
31	829.468E-6	0.397	3.00	PASS
32	618.478E-6	0.296		PASS
33	955.132E-6	0.457	3.00	PASS
34	636.128E-6	0.304		PASS
35	1.500E-3	0.717	3.00	PASS
36	576.647E-6	0.276		PASS
37	958.335E-6	0.458	3.00	PASS
38	588.266E-6	0.281		PASS
39	1.361E-3	0.651	3.00	PASS
40	647.027E-6	0.310		PASS



9. VOLTAGE FLUCTUATIONS & FLICKER TEST

9.1. Block Diagram of Test Setup

Same as Section 8.1..

9.2. Test Standard

EN61000-3-3:2013

9.3. Operating Condition of EUT

Same as Section 8.3.. The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test.

Flicker Test Limit

Test items	Limits
Pst	1.0
dc	3.3%
dmax	4.0%
dt	Not exceed 3.3% for 500ms

9.4. Test Data

Flicker test Data

Model No.: ST64

Test Mode: 1

Items	Reading	Limit
dmax	0.01	4.0%
dc	0.03	3.3%
dt	0.05	Not exceed 3.3% for 500ms
Pst	0.001	1.0

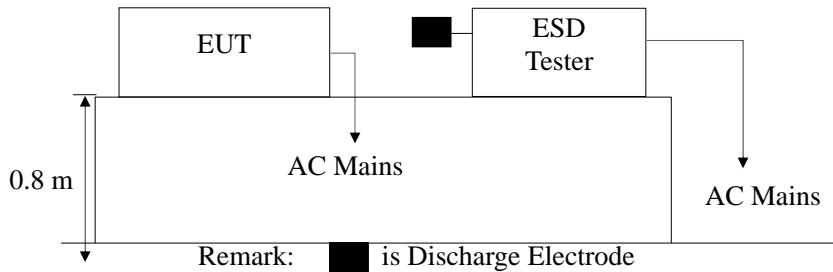
9.5. Test Results

PASS.



10.ELECTROSTATIC DISCHARGE TEST

10.1.Block Diagram of ESD Test Setup



10.2.Test Standard

EN61547:2009 (EN61000-4-2:2009)
Severity Level 3 for Air Discharge at 8KV
Severity Level 2 for Contact Discharge at 4KV

10.3.Severity Levels and Performance Criterion

10.3.1.Severity level

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)
1.	2	2
2.	4	4
3.	6	8
4.	8	15
X.	Special	Special

10.3.2.Performance criterion: B

10.4.EUT Configuration on Test

The configuration of EUT are listed in Section 3.2.



10.5.Operating Condition of EUT

- 10.5.1.Setup the EUT as shown in Section 10.1.
- 10.5.2.Turn on the power of all equipments.
- 10.5.3.Let the EUT work in test mode (ON) and test it.

10.6.Test Procedure

10.6.1.Air Discharge:

This test is done on a non-conductive surfaces. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT.
After each discharge, the discharge electrode shall be removed from the EUT.
The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

10.6.2.Contact Discharge:

All the procedure shall be same as Section 10.6.1. except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

10.6.3.Indirect discharge for horizontal coupling plane

At least 20 single discharges shall be applied to the horizontal coupling plane, at points on each side of the EUT. The discharge electrode positions vertically at a distance of 0.1m from the EUT and with the discharge electrode touching the coupling plane.

10.6.4.Indirect discharge for vertical coupling plane

At least 20 single discharge shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

10.7.Test Results

PASS.



Electrostatic Discharge Test Results

Shenzhen BST Technology Co., Ltd.

Applicant	: DONGGUAN VENUS OPTOELECTRONIC CO.,LTD	Test Date	: Sept. 13, 2016
EUT	: LED FILAMENT BULB	Temperature	: 22 °C
M/N	: ST64	Humidity	: 50 %
Power Supply	: AC 230V, 50Hz	Test Mode	: ON

Air Discharge: $\pm 8KV$ For each point positive 10 times and negative 10 times discharge.

Contact Discharge: $\pm 4KV$

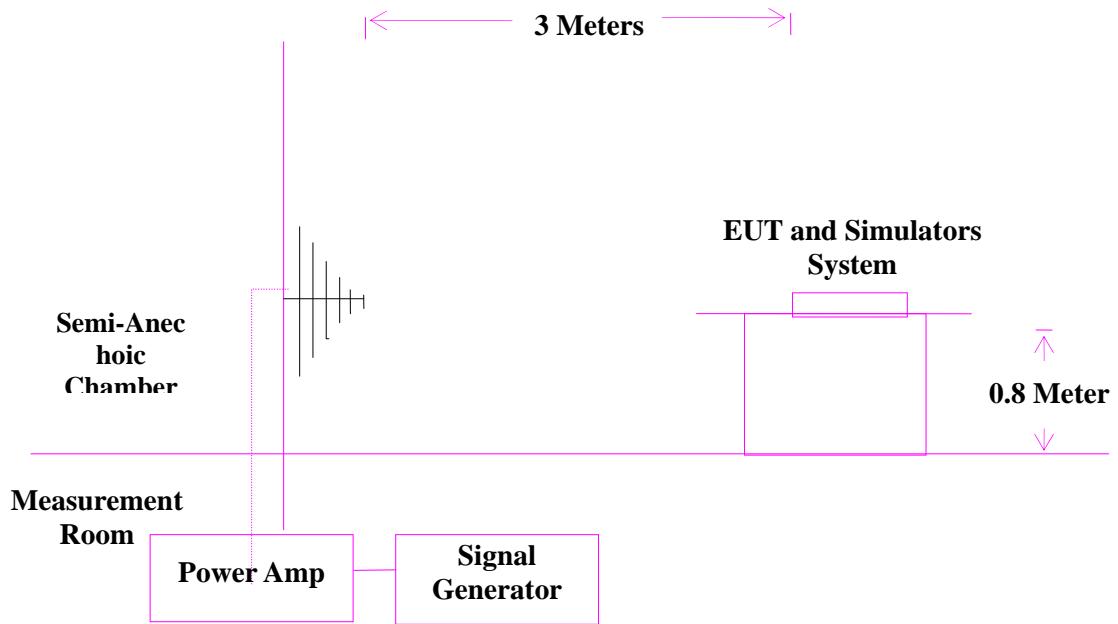
Location	Kind A-Air Discharge C-Contact Discharge	Result	
		A	C
Slots	A	PASS	
Metal Parts	C	PASS	
HCP	C	PASS	
VCP	C	PASS	

Discharge should be considered on Contact and Air and Horizontal Coupling Plane (HCP) and Vertical Coupling Plane (VCP).



11. RF FIELD STRENGTH SUSCEPTIBILITY TEST

11.1.R/S Test Setup



11.2.Test Standard

EN61547:2009 (EN 61000-4-3:2006 + A1:2008 + A2:2010)
Severity Level 2 at 3V / m

11.3.Severity Levels and Performance Criterion

11.3.1.Severity level

Level	Field Strength V/m
1.	1
2.	3
3.	10
X.	Special

11.3.2.Performance criterion : A



11.4.EUT Configuration on Test

The configuration of EUT are listed in Section 3.2.

11.5.Operating Condition of EUT

Setup the EUT as shown in Section 11.1.. The operating condition of EUT are listed in section 3.3.

11.6.Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above the ground. The EUT is set 3 meters away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually. In order to judge the EUT performance, a CCD camera is used to monitor the EUT. All the scanning conditions are as follows :

Condition of Test	Remarks
1. Fielded Strength	3 V/m (Severity Level 2)
2. Radiated Signal	Modulated
3. Scanning Frequency	80 - 1000 MHz, 1.4GHz-2.7GHz
4. Sweeping time of radiated	0.0015 decade/s
5. Dwell Time	1 Sec.

11.7.Test Results

PASS.

Please refer to the following page.



Shenzhen BST Technology Co.,Ltd.

Report No.: BST1501396490001Y-IER-1

RF Field Strength Susceptibility Test Results

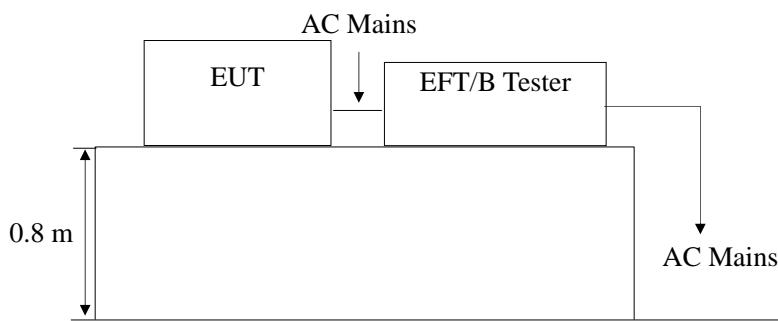
Shenzhen BST Technology Co., Ltd.

Applicant	: DONGGUAN VENUS OPTOELECTRONIC CO.,LTD		Test Date	: Sept. 13, 2016			
EUT	: LED FILAMENT BULB		Temperature	: 22 °C			
M/N	: ST64		Humidity	: 50 %			
Power Supply	: AC 230V, 50Hz		Test Mode	: ON			
Frequency Range :	80 MHz to 1000 MHz, 1.4GHz-2.7GHz						
Modulation:	<input checked="" type="checkbox"/> AM <input type="checkbox"/> Pulse <input type="checkbox"/> Phone 1 KHz 80%						
Criterion : A							
	Frequency Rang : 80-1000MHZ, 1.4GHz-2.7GHz						
Steps	1%		1%				
	Horizontal		Vertical				
Front	Pass		Pass				
Right	Pass		Pass				
Rear	Pass		Pass				
Left	Pass		Pass				



12.ELECTRICAL FAST TRANSIENT/BURST TEST

12.1.EFT Test Setup



12.2.Test Standard

EN61547:2009 (EN61000-4-4:2012)
Severity Level 2 at 1KV

12.3.Severity Levels and Performance Criterion

12.3.1.Severity level

Open Circuit Output Test Voltage ±10%		
Level	On Power Supply Lines	On I/O (Input/Output) Signal data and control lines
1.	0.5 KV	0.25 KV
2.	1 KV	0.5 KV
3.	2 KV	1 KV
4.	4 KV	2 KV
X	Special	Special

12.3.2.Performance criterion : B

12.4.EUT Configuration on Test

The configuration of EUT are listed in Section 3.2..

12.5.Operating Condition of EUT

Setup the EUT as shown in Section 12.1.. The operating condition of EUT are listed in section 3.3.



12.6. Test Procedure

The EUT is put on the table which is 0.8 meter high above the ground. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between the EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m.

12.6.1. For input and output AC power ports:

The EUT is connected to the power mains by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 mins.

12.6.2. For signal lines and control lines ports:

It's unnecessary to test.

12.6.3. For DC output line ports:

It's unnecessary to test.

12.7. Test Results

PASS.

Please refer to the following page.



Electrical Fast Transient/Burst Test Results

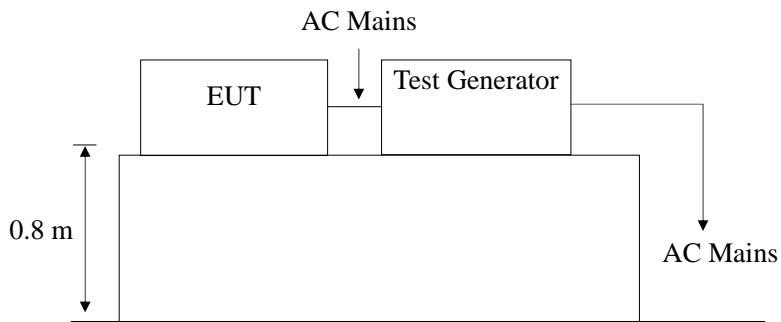
Shenzhen BST Technology Co., Ltd.

Applicant	DONGGUAN VENUS OPTOELECTRONIC CO.,LTD				Test Date	Sept. 13, 2016			
EUT	LED FILAMENT BULB				Temperature	22 °C			
M/N	ST64				Humidity	50 %			
Power Supply	AC 230V, 50Hz				Test Mode	ON			
Inject Place : AC Mains									
Inject Line	Voltage KV	Inject Time(s)	Inject Method	Results	Inject Line	Voltage KV	Inject Time(s)	Inject Method	Results
L	±1	120	Direct	PASS					
N	±1	120	Direct	PASS					
L N	±1	120	Direct	PASS					



13.SURGE TEST

13.1.Surge Test Setup



13.2.Test Standard

EN61547:2009 (EN61000-4-5:2006)
Severity Level 2 for Line to Neutral at 1.0KV

13.3.Severity Levels and Performance Criterion

13.3.1.Severity level

Severity Level	Open-Circuit Test Voltage KV
1	0.5
2	1.0
3	2.0
4	4.0
*	Special

Performance criterion : **B**

13.4.EUT Configuration on Test

The configuration of EUT are listed in Section 3.2.

13.5.Operating Condition of EUT

13.5.1.Setup the EUT as shown in Section 13.1..

13.5.2.Turn on the power of all equipments.

13.5.3.Let the EUT work in test mode (ON) and test it..



13.6.Test Procedure

- 1) Set up the EUT and test generator as shown on Section 13.1
- 2) For line to line coupling mode, provide a 1KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.
- 3) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test.
- 4) Different phase angles are done individually.
- 5) Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

13.7.Test Results

PASS.

Please refer to the following page.



Surge Immunity Test Results

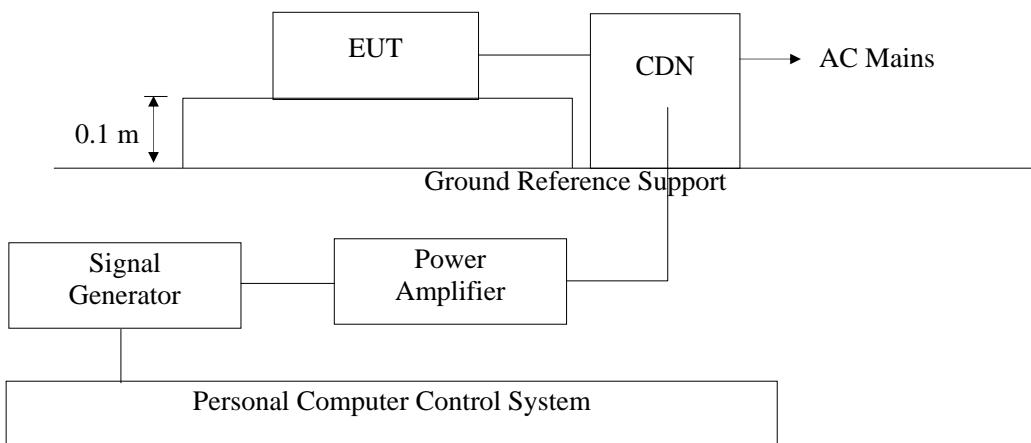
Shenzhen BST Technology Co., Ltd.

Applicant	DONGGUAN VENUS OPTOELECTRONIC CO.,LTD			Test Date	Sept. 13, 2016
EUT	LED FILAMENT BULB			Temperature	22 °C
M/N	ST64			Humidity	50 %
Power Supply	AC 230V, 50Hz			Test Mode	ON
Location	Polarity	Phase Angle	No of Pulse	Pulse Voltage (KV)	Result
L-N	+	0	5	1.0	PASS
	+	90	5	1.0	PASS
	+	180	5	1.0	PASS
	+	270	5	1.0	PASS
	-	0	5	1.0	PASS
	-	90	5	1.0	PASS
	-	180	5	1.0	PASS
	-	270	5	1.0	PASS



14. INJECTED CURRENTS SUSCEPTIBILITY TEST

14.1. Block Diagram of Test AC Mains Setup



14.2. Test Standard

EN61547:2009 (EN61000-4-6:2009)
Severity Level 2 at 3 V (rms), 0.15MHz ~ 80MHz

14.3. Severity Levels and Performance Criterion

14.3.1. Severity level

Level	Field Strength V/m
1.	1
2.	3
3.	10
X	Special

14.3.2. Performance criterion: A

14.4. EUT Configuration on Test

The configuration of EUT are listed in Section 3.2.

14.5. Operating Condition of EUT

Setup the EUT as shown in Section 14.1.. The operating condition of EUT are listed in section 3.3.



14.6. Test Procedure

- 1) Set up the EUT, CDN and test generators as shown on Section 14.1.
- 2) Let the EUT work in test mode and test it.
- 3) The EUT are placed on an insulating support 0.8m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane about 0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).
- 4) The disturbance signal described below is injected to EUT through CDN.
- 5) The EUT operates within its operational mode(s) under intended climatic conditions after power on.
- 6) The frequency range is swept from 150KHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1KHz sine wave.
- 7) The rate of sweep shall not exceed 1.5×10^{-3} decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- 8) Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.

14.7. Test Results

PASS.

Please refer to the following page.



Injected Currents Susceptibility Test Results

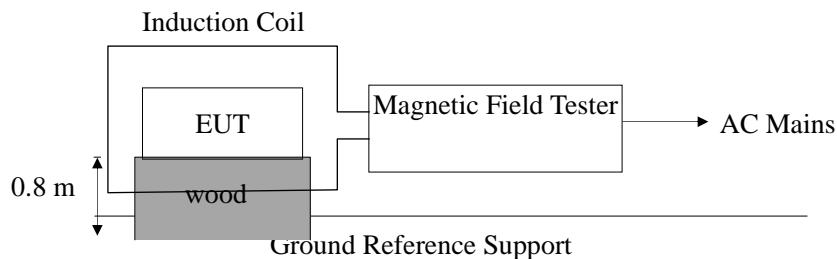
Shenzhen BST Technology Co., Ltd.

Applicant	: DONGGUAN VENUS OPTOELECTRONIC CO.,LTD		Test Date	: Sept. 13, 2016	
EUT	: LED FILAMENT BULB		Temperature	: 22 °C	
M/N	: ST64		Humidity	: 50 %	
Power Supply	: AC 230V, 50Hz		Test Mode	: ON	
Frequency Range (MHz)	Injected Position	Strength	Criterion	Result	
0.15 ~ 20	AC Line	3V(rms), Unmodulated	A	PASS	
20 ~ 80	AC Line	3V(rms), Unmodulated	A	PASS	
			Note:		



15.MAGNETIC FIELD IMMUNITY TEST

15.1.Block Diagram of Test Setup



15.2.Test Standard

EN61547:2009 (EN61000-4-8:2010)
Severity Level 2 at 3A/m

15.3.Severity Levels and Performance Criterion

15.3.1.Severity level

Level	Magnetic Field Strength A/m
1.	1
2.	3
3.	10
4.	30
5.	100
X.	Special

15.3.2.Performance criterion : A

15.4.EUT Configuration on Test

The configuration of EUT are listed in Section 3.2.

15.5.Operating Condition of EUT

15.5.1.Setup the EUT as shown in Section 15.1

15.5.2.Turn on the power of all equipments.

15.5.3.Let the EUT work in test mode (ON) and test it.



15.6. Test Procedure

The EUT shall be subjected to the test magnetic field by using the induction coil of standard dimensions (1m*1m) and shown in Section 15.1. The induction coil shall then be rotated by 90° in order to expose the EUT to the test field with different orientations.

15.7. Test Results

PASS.

Please refer to the following page.



Magnetic Field Immunity Test Results

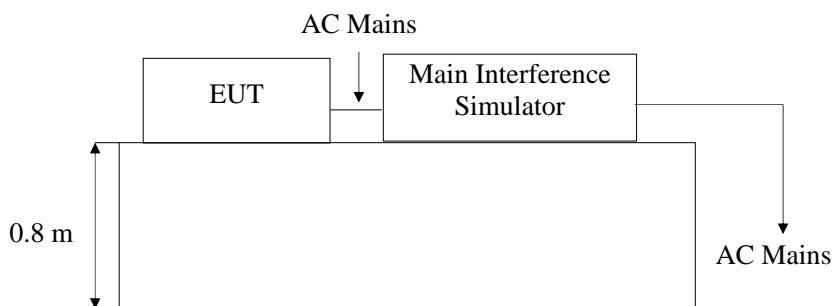
Shenzhen BST Technology Co.,Ltd.

<p>Applicant : DONGGUAN VENUS OPTOELECTRONIC CO.,LTD</p> <p>EUT : LED FILAMENT BULB</p> <p>M/N : ST64</p> <p>Power Supply : AC 230V, 50Hz</p>		<p>Test Date : Sept. 13, 2016</p> <p>Temperature : 22 °C</p> <p>Humidity : 60 %</p>																	
<p>Test Mode: ON</p> <table border="1"><thead><tr><th>Test Level</th><th>Testing Duration</th><th>Coil Orientation</th><th>Criterion</th><th>Result</th></tr></thead><tbody><tr><td>3A/M</td><td>5 mins</td><td>Horizontal</td><td>A</td><td>PASS</td></tr><tr><td>3A/M</td><td>5 mins</td><td>Vertical</td><td>A</td><td>PASS</td></tr></tbody></table>					Test Level	Testing Duration	Coil Orientation	Criterion	Result	3A/M	5 mins	Horizontal	A	PASS	3A/M	5 mins	Vertical	A	PASS
Test Level	Testing Duration	Coil Orientation	Criterion	Result															
3A/M	5 mins	Horizontal	A	PASS															
3A/M	5 mins	Vertical	A	PASS															
Remark:		Test Equipment : Magnetic Field Tester MAG100.1																	



16. VOLTAGE DIPS AND INTERRUPTIONS TEST

16.1. Voltage Dips and Interruptions Test Setup



Remark: Combination wave generator and decoupling network are included in test generator.

16.2. Test Standard

EN61547:2009 (EN61000-4-11:2004)

16.3. Severity Levels and Performance Criterion

16.3.1. Severity level

Test Level % UT	Voltage dip and short interruptions % UT	Duration (in period)
0	100	250p
40	60	5p
70	30	0.5p

16.3.2. Performance criterion : C&B

16.4. EUT Configuration on Test

The configuration of EUT are listed in Section 3.2.

16.5. Operating Condition of EUT

16.5.1. Setup the EUT as shown in Section 16.1..

16.5.2. Turn on the power of all equipments.

16.5.3. Let the EUT work in test mode (ON) and test it.



16.6. Test Procedure

- 1) Set up the EUT and test generator as shown on Section 16.1.
- 2) The interruptions is introduced at selected phase angles with specified duration.
- 3) Record any degradation of performance.

16.7. Test Result

PASS.

Please refer to the following page.



Voltage Dips And Interruptions Test Results

Shenzhen BST Technology Co., Ltd

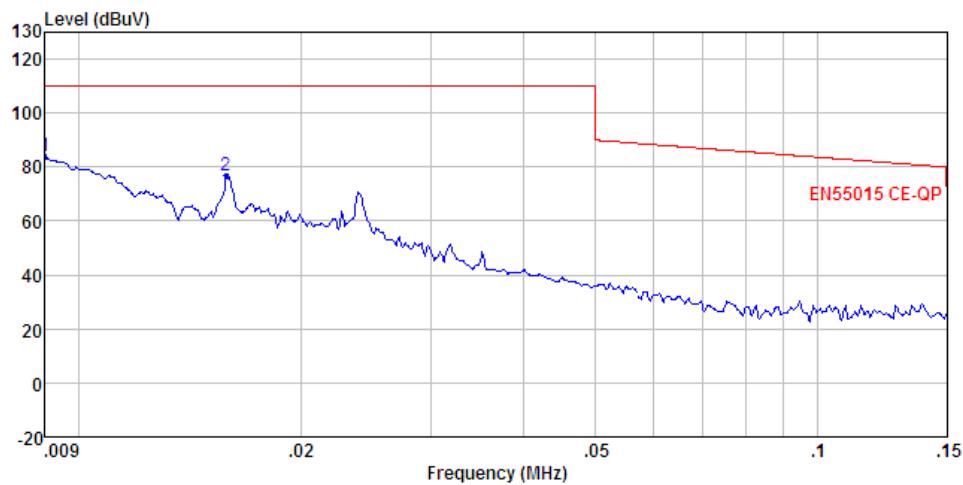
Applicant : DONGGUAN VENUS OPTOELECTRONIC CO.,LTD		Test Date : Sept. 13, 2016			
EUT : LED FILAMENT BULB		Temperature : 22 °C			
M/N : ST64		Humidity : 64 %			
Power Supply : AC 230V, 50Hz					
<u>Test Mode: ON</u>					
Test Level % U_T	Voltage Dips & Short Interruptions % U_T	Duration (in period)	Phase Angle	Criterion	Result
70	30	10P	90°	C	PASS
0	100	0.5P	180°	B	PASS
Remark: U_T is the rated voltage for the equipment.			Test Equipment : Main Interference Simulator (HEAFELY PLINE1610)		



Shenzhen BST Technology Co.,Ltd.

Report No.: BST1501396490001Y-IER-1

APPENDIX I

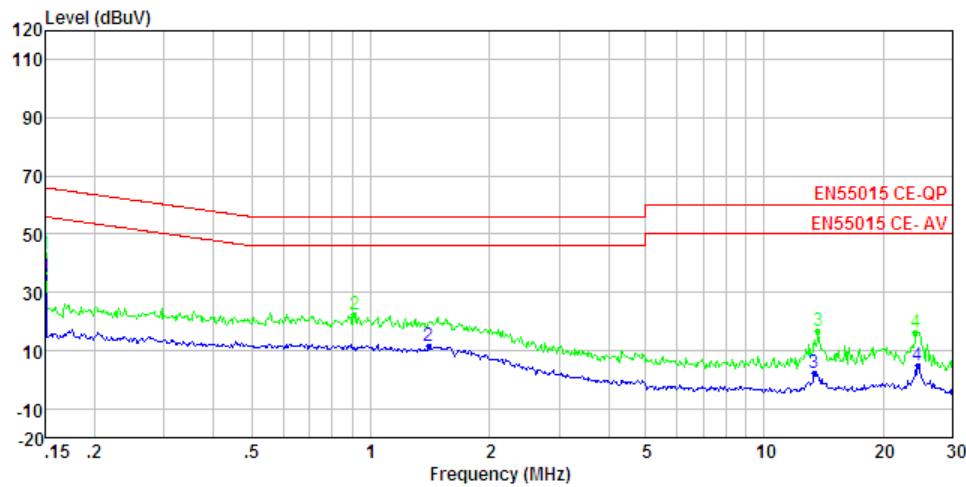


Site : Shenzhen BST Technology Co.,Ltd.

Condition:

: RBW:0.200KHz VBW:30.000KHz

Freq	Level	Limit	Over	Remark	Pol/Phase
MHz	dBuV	dBuV	dB		
1 Max	0.009	84.0	110.0	-26.0 Peak	LINE
2	0.016	76.7	110.0	-33.3 Peak	LINE



Site : Shenzhen BST Technology Co.,Ltd.

Condition:

: RBW:9.000KHz VBW:30.000KHz

Limit Over

Freq	Level	Line	Limit	Remark	Pol/Phase
------	-------	------	-------	--------	-----------

MHz	dBuV	dBuV	dB		
-----	------	------	----	--	--

1 Max	0.150	35.5	56.0	-20.5 Average	LINE
2	1.403	11.5	46.0	-34.5 Average	LINE
3	13.408	2.0	50.0	-48.0 Average	LINE
4	24.529	5.0	50.0	-45.0 Average	LINE

Site : Shenzhen BST Technology Co.,Ltd.

Condition:

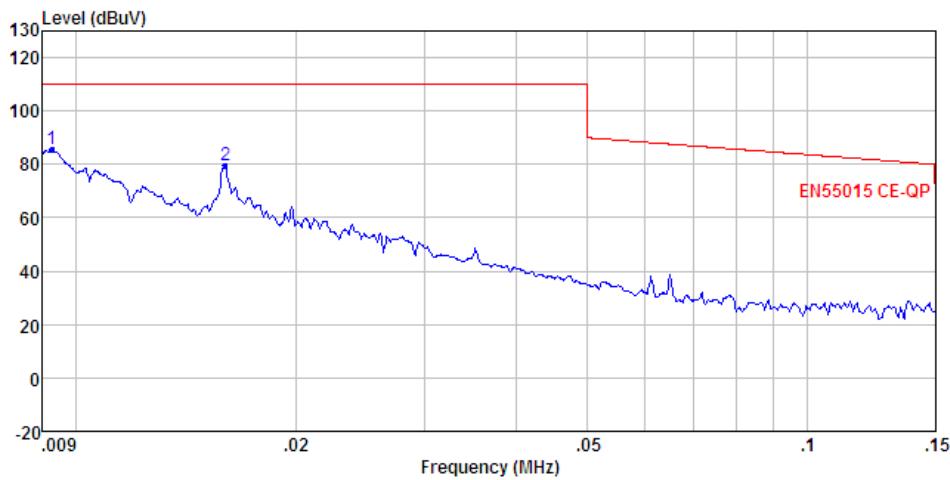
: RBW:9.000KHz VBW:30.000KHz

Limit Over

Freq	Level	Line	Limit	Remark	Pol/Phase
------	-------	------	-------	--------	-----------

MHz	dBuV	dBuV	dB		
-----	------	------	----	--	--

1 Max	0.150	43.2	66.0	-22.8 Peak	LINE
2	0.909	22.3	56.0	-33.7 Peak	LINE
3	13.695	16.5	60.0	-43.5 Peak	LINE
4	24.142	16.1	60.0	-43.9 Peak	LINE

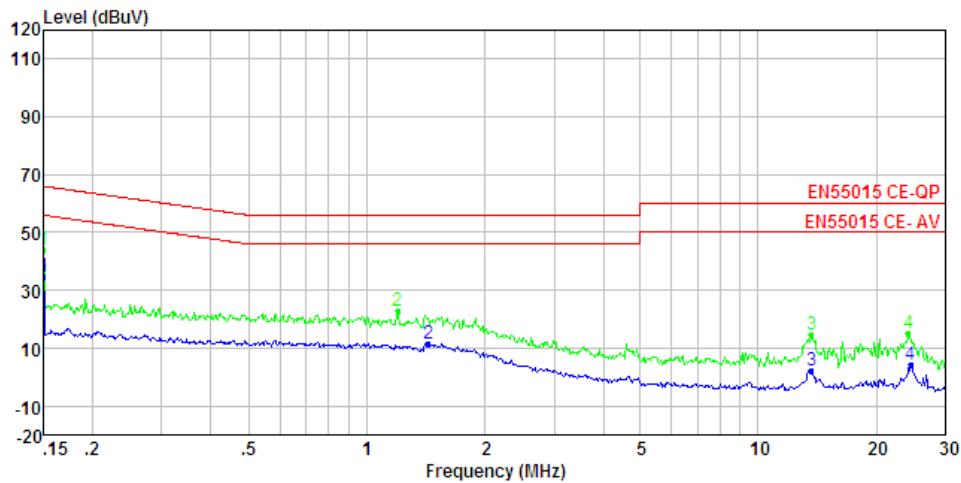


Site : Shenzhen BST Technology Co.,Ltd.

Condition:

: RBW:0.200KHz VBW:30.000KHz

Freq MHz	Level dBuV	Limit		Over dB	Remark	Pol/Phase
		Line dBuV	Limit dB			
1 Max 0.009	85.4	110.0	-24.6	Peak	NEUTRAL	
2 0.016	79.6	110.0	-30.4	Peak	NEUTRAL	



Site : Shenzhen BST Technology Co.,Ltd.

Condition:

: RBW:9.000KHz VBW:30.000KHz

Freq	Level	Limit	Over	Remark	Pol/Phase
MHz	dBuV	dBuV	dB		

1 Max	0.150	35.0	56.0	-21.0 Average	NEUTRAL
2	1.433	11.6	46.0	-34.4 Average	NEUTRAL
3	13.695	2.2	50.0	-47.8 Average	NEUTRAL
4	24.529	4.3	50.0	-45.7 Average	NEUTRAL

Site : Shenzhen BST Technology Co.,Ltd.

Condition:

: RBW:9.000KHz VBW:30.000KHz

Freq	Level	Limit	Over	Remark	Pol/Phase
MHz	dBuV	dBuV	dB		

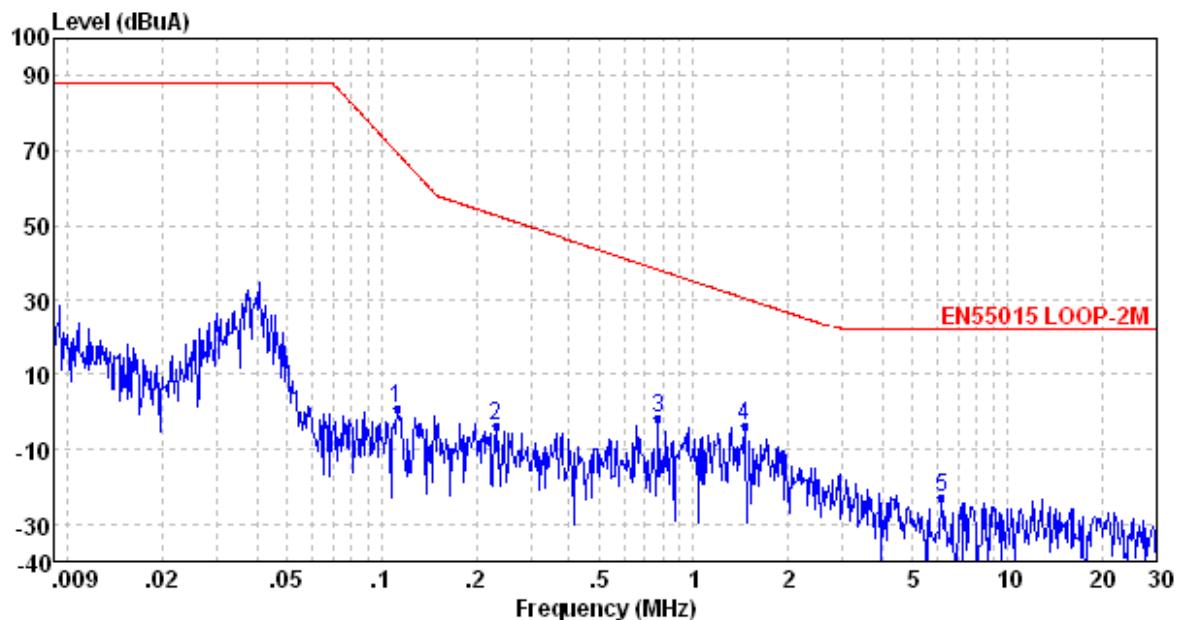
1 Max	0.150	44.1	66.0	-21.9 Peak	NEUTRAL
2	1.197	22.8	56.0	-33.2 Peak	NEUTRAL
3	13.695	14.7	60.0	-45.3 Peak	NEUTRAL
4	24.142	15.3	60.0	-44.7 Peak	NEUTRAL



Shenzhen BST Technology Co.,Ltd.

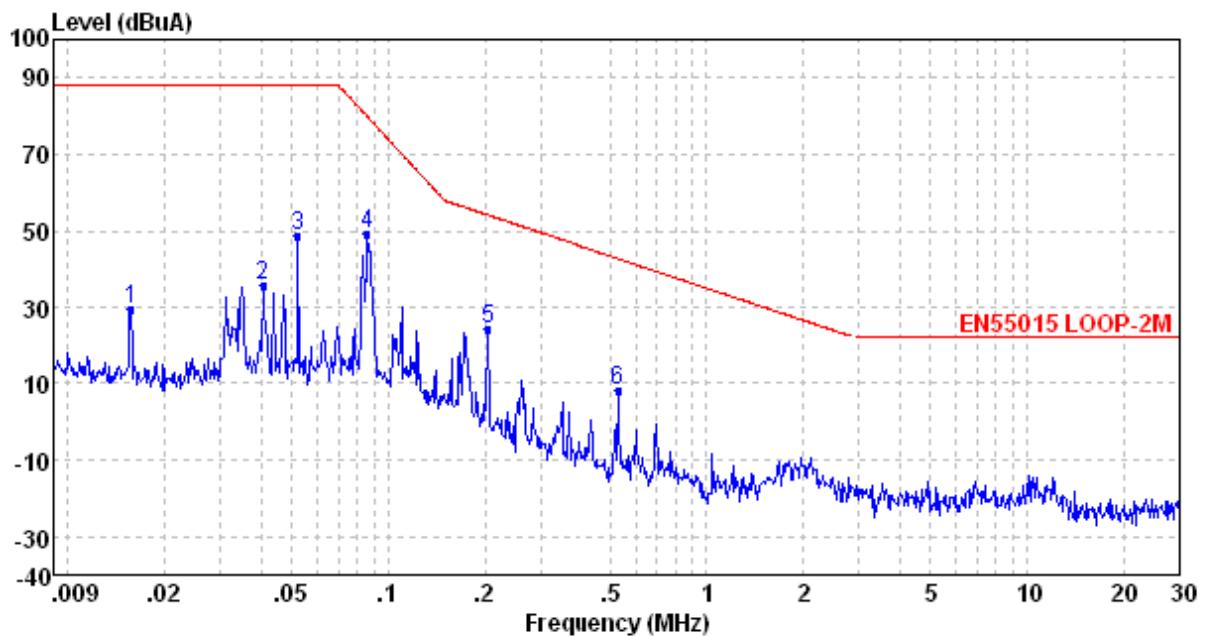
Report No.: BST1501396490001Y-IER-1

APPENDIX II



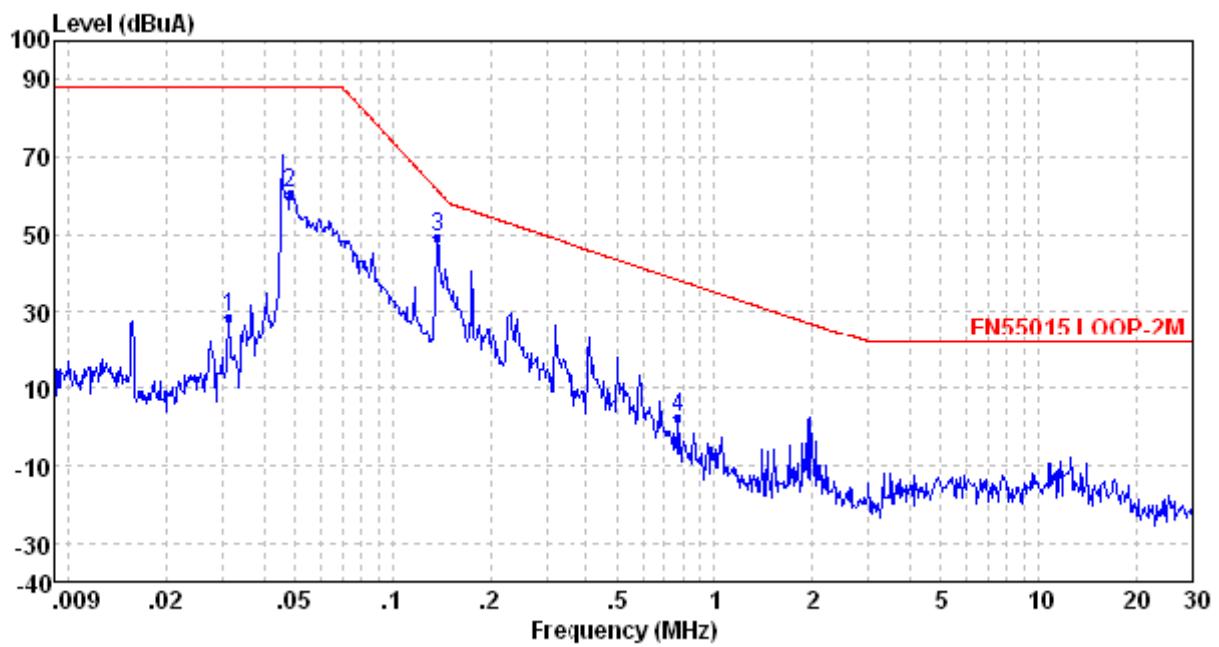
Site : Shenzhen BST Technology Co.,Ltd.

	Freq	Level	Limit Over		Pol/Phase
			MHz	dBuA	
1	0.11	0.97	69.46	-68.49	
2	0.23	-4.00	52.84	-56.84	
3	0.77	-2.01	38.31	-40.32	
4 Max	1.46	-4.05	30.71	-34.76	
5	6.17	-23.00	22.02	-45.02	



Site : Shenzhen BST Technology Co.,Ltd.
Limit Over
Freq Level Line Limit Pol/Phase

MHz dBuA dBuA dB
1 0.02 29.97 88.02 -58.05
2 0.04 35.83 88.02 -52.19
3 0.05 48.65 88.02 -39.37
4 0.09 49.34 80.00 -30.66
5 Max 0.20 24.42 54.30 -29.88
6 0.53 8.12 42.89 -34.77



Site : Shenzhen BST Technology Co., Ltd.

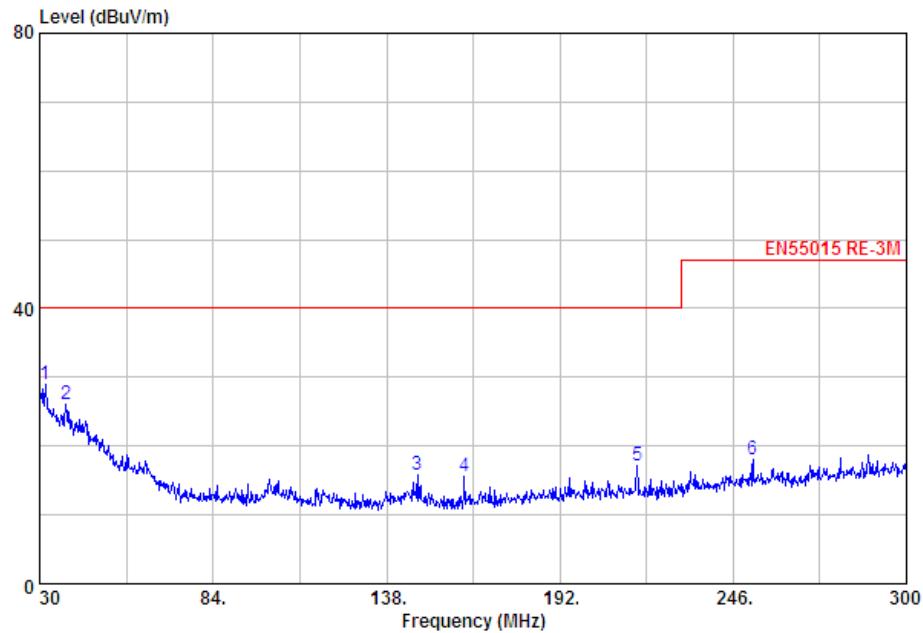
	Freq	Level	Limit	Over	Line	Limit	Pol/Phase
	MHz	dBuA	dBuA			dB	
1	0.03	28.64	88.02	-	59.38		
2	0.05	60.78	88.02	-	27.24		
3 Max	0.14	49.12	61.48	-	12.36		
4	0.77	2.43	38.31	-	35.88		



Shenzhen BST Technology Co.,Ltd.

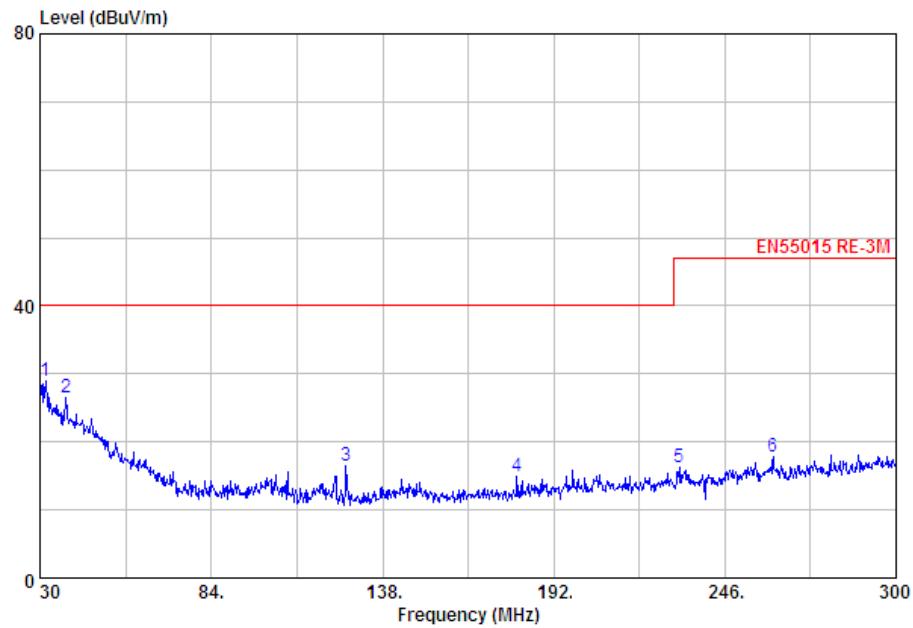
Report No.: BST1501396490001Y-IER-1

APPENDIX III



Condition : EN55015 RE-3M 3m HORIZONTAL
: RBW:120.000KHz VBW:300.000KHz SWT:Auto
: Shenzhen BST Technology Co.,Ltd.

	Freq	Limit	Over		
	MHz	Line	Level	Limit	Remark
1	max	31.890	40.0	28.9	-11.1 Peak
2	38.100	40.0	26.1	-13.9 Peak	HORIZONTAL
3	147.450	40.0	15.9	-24.1 Peak	HORIZONTAL
4	162.030	40.0	15.6	-24.4 Peak	HORIZONTAL
5	216.300	40.0	17.2	-22.8 Peak	HORIZONTAL
6	252.210	47.0	18.1	-28.9 Peak	HORIZONTAL



Condition : EN55015 RE-3M 3m VERTICAL
: RBW:120.000KHz VBW:300.000KHz SWT:Auto
: Shenzhen BST Technology Co.,Ltd.

Freq MHz	Limit		Over dB	Remark	Pol/Phase
	Line dBuV/m	Level dBuV/m			
1 max	31.890	40.0	28.9	-11.1 Peak	VERTICAL
2	38.100	40.0	26.5	-13.5 Peak	VERTICAL
3	126.390	40.0	16.4	-23.6 Peak	VERTICAL
4	180.120	40.0	14.9	-25.1 Peak	VERTICAL
5	231.690	47.0	16.2	-30.8 Peak	VERTICAL
6	261.390	47.0	17.8	-29.2 Peak	VERTICAL



Shenzhen BST Technology Co.,Ltd.

Report No.: BST1501396490001Y-IER-1

APPENDIX IV



Photo 1 General Appearance of the EUT

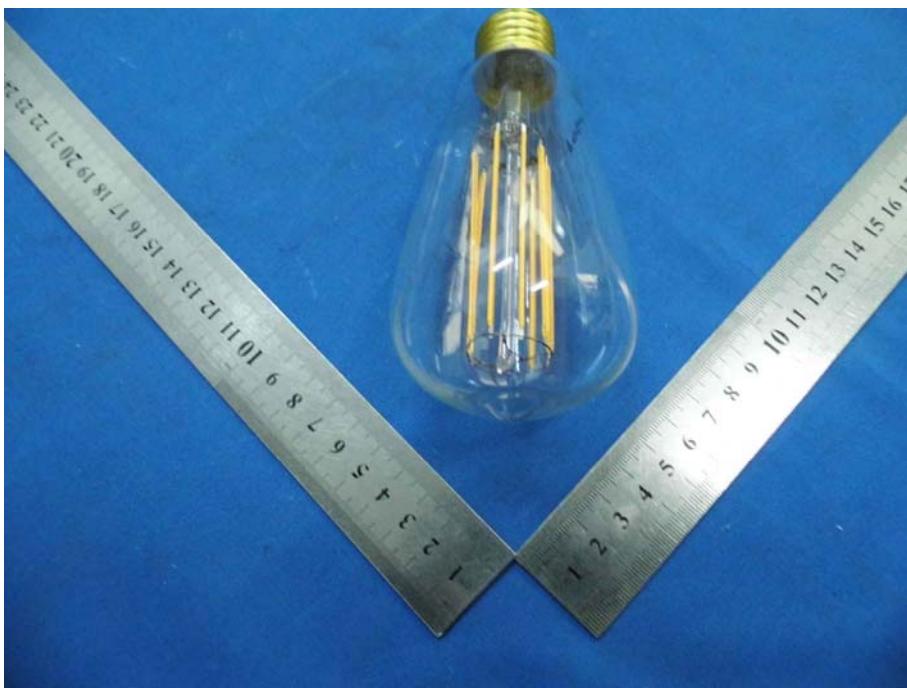


Photo 2 General Appearance of the EUT

